Search Notes



Applica	tion	/Con	trol	No.

Applicant(s)/Patent under Reexamination
KICHISE, MIKI

09/829,971

Examiner

Art Unit

CHUONG T. HO

2664

	SEARCHED				
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Application/Control No.	Applic Reexa
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09/829,97 Examiner

CHUONG T. HO

Applicant(s)/Patent under
Reexamination
KICHISE, MIKI
Art Unit

2664

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